

<b>Notice of References Cited</b>	Application/Control No. 10/578,025	Applicant(s)/Patent Under Reexamination SHIKATA ET AL.	
	Examiner NOAH S. WIESE	Art Unit 1793	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,525,560	06-1996	Yamazaki et al.	501/103
*	B	US-2002/0010070	01-2002	Cales et al.	501/105
*	C	US-7,148,167	12-2006	Shikata et al.	501/105
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP-2000-191372-A	07-2000	JP	Yoshida et al	C04B 35/48
	O					
	P					
	Q					
	R					
	S					
	I					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.